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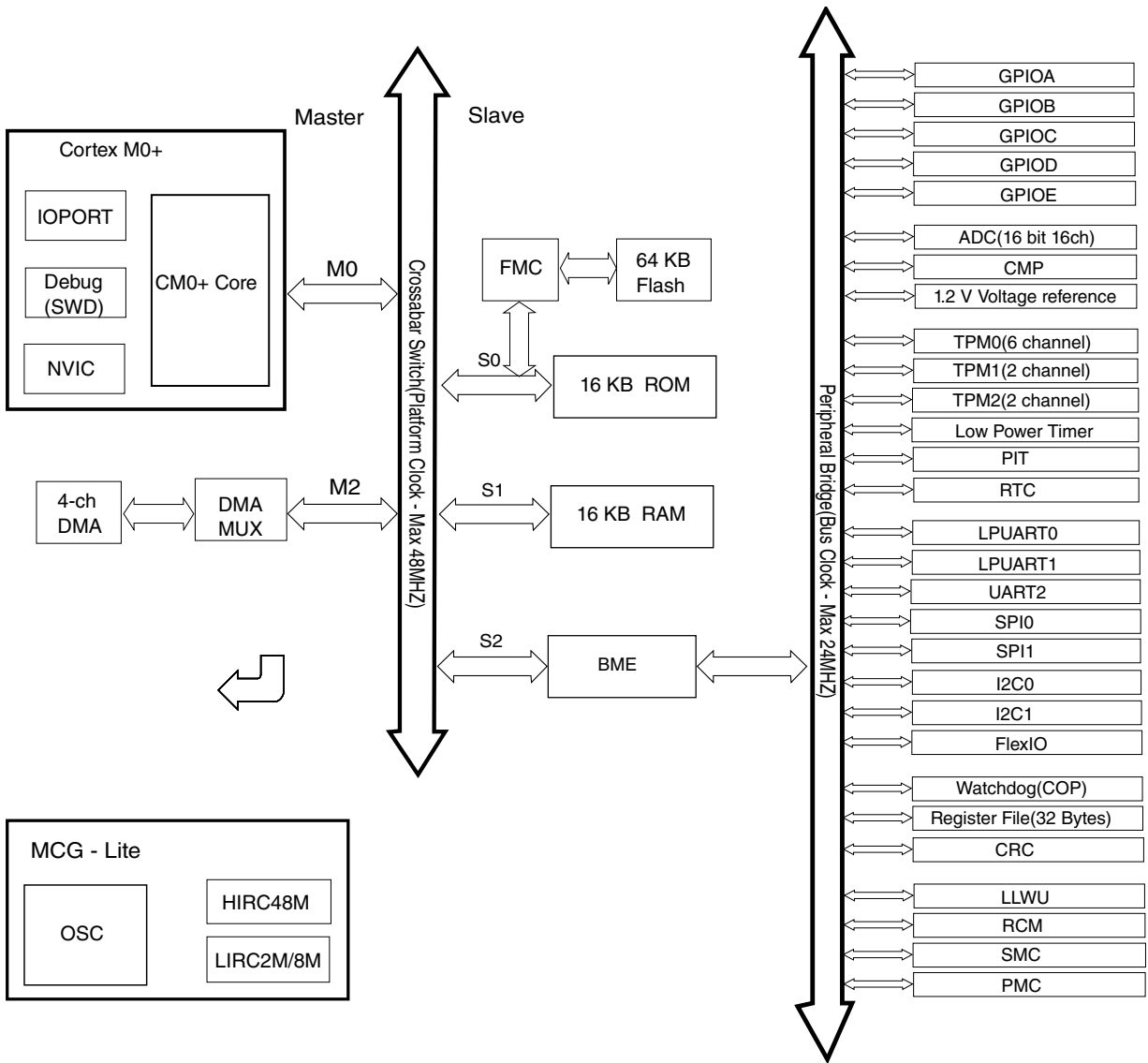
### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	ARM® Cortex®-M0+
Core Size	32-Bit Single-Core
Speed	48MHz
Connectivity	I <sup>2</sup> C, FlexIO, SPI, UART/USART
Peripherals	DMA, I <sup>2</sup> S, PWM, WDT
Number of I/O	54
Program Memory Size	32KB (32K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	8K x 8
Voltage - Supply (Vcc/Vdd)	1.71V ~ 3.6V
Data Converters	A/D 20x16b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LQFP (10x10)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/nxp-semiconductors/mkl17z32vlh4">https://www.e-xfl.com/product-detail/nxp-semiconductors/mkl17z32vlh4</a>



**Figure 1. System diagram**

The crossbar switch connects bus masters and slaves using a crossbar switch structure. This structure allows up to four bus masters to access different bus slaves simultaneously, while providing arbitration among the bus masters when they access the same slave.

## 2.1 System features

The following sections describe the high-level system features.

**Table 2. AWIC stop wake-up sources (continued)**

Wake-up source	Description
I <sup>2</sup> Cx	Address match wakeup
LPUART0 , LPUART1	Any enabled interrupt can be a source as long as the module remains clocked
UART2	Active edge on RXD
RTC	Alarm or seconds interrupt
NMI	NMI pin
TPMx	Any enabled interrupt can be a source as long as the module remains clocked
LPTMR	Any enabled interrupt can be a source as long as the module remains clocked
SPIx	Slave mode interrupt
FlexIO	Any enabled interrupt can be a source as long as the module remains clocked

### 2.1.4 Memory

This device has the following features:

- 8/16 KB of embedded RAM accessible (read/write) at CPU clock speed with 0 wait states.
- The non-volatile memory is divided into two arrays
  - 32/64 KB of embedded program memory
  - 16 KB ROM (built-in bootloader to support UART, I2C, and SPI interfaces)

The program flash memory contains a 16-byte flash configuration field that stores default protection settings and security information. The page size of program flash is 1 KB.

The protection setting can protect 32 regions of the program flash memory from unintended erase or program operations.

The security circuitry prevents unauthorized access to RAM or flash contents from debug port.

- System register file

This device contains a 32-byte register file that is powered in all power modes.

Also, it retains contents during low power modes and is reset only during a power-on reset.

**Table 4. Module clocks**

Module	Bus interface clock	Internal clocks	I/O interface clocks
<b>Core modules</b>			
ARM Cortex-M0+ core	Platform clock	Core clock	—
NVIC	Platform clock	—	—
DAP	Platform clock	—	SWD_CLK
<b>System modules</b>			
DMA	System clock	—	—
DMA Mux	Bus clock	—	—
Port control	Bus clock	—	—
Crossbar Switch	Platform clock	—	—
Peripheral bridges	System clock	Bus clock	—
LLWU, PMC, SIM, RCM	Bus clock	LPO	—
Mode controller	Bus clock	—	—
MCM	Platform clock	—	—
COP watchdog	Bus clock	LPO, Bus Clock, MCGIRCLK, OSCERCLK	—
CRC	Bus clock	—	—
<b>Clocks</b>			
MCG_Lite	Bus clock	MCGOUTCLK, MCGPCLK, MCGIRCLK, OSCERCLK, ERCLK32K	—
OSC	Bus clock	OSCERCLK	—
<b>Memory and memory interfaces</b>			
Flash Controller	Platform clock	Flash clock	—
Flash memory	Flash clock	—	—
<b>Analog</b>			
ADC	Bus clock	OSCERCLK	—
CMP	Bus clock	—	—
Internal Voltage Reference (VREF)	Bus clock	—	—
<b>Timers</b>			
TPM	Bus clock	TPM clock	TPM_CLKIN0, TPM_CLKIN1
PIT	Bus clock	—	—
LPTMR	Bus clock	LPO, OSCERCLK, MCGPCLK, ERCLK32K	—
RTC	Bus clock	ERCLK32K	RTC_CLKOUT, RTC_CLKIN
<b>Communication interfaces</b>			
SPI0	Bus clock	—	SPI0_SCK
SPI1	System clock	—	SPI1_SCK
I <sup>2</sup> C0	System Clock	—	I2C0_SCL

Table continues on the next page...

**Table 4. Module clocks (continued)**

Module	Bus interface clock	Internal clocks	I/O interface clocks
I <sup>2</sup> C1	System Clock	—	I2C1_SCL
LPUART0, LPUART1	Bus clock	LPUART0 clock LPUART1 clock	—
UART2	Bus clock	—	—
FlexIO	Bus clock	FlexIO clock	—
<b>Human-machine interfaces</b>			
GPIO	Platform clock	—	—

## 2.1.7 Security

Security state can be enabled via programming flash configuration field (0x40e). After enabling device security, the SWD port cannot access the memory resources of the MCU, and ROM boot loader is also limited to access flash and not allowed to read out flash information via ROM boot loader commands.

Access interface	Secure state	Unsecure operation
SWD port	Cannot access memory source by SWD interface	The debugger can write to the Flash Mass Erase in Progress field of the MDM-AP Control register to trigger a mass erase (Erase All Blocks) command
ROM boot loader Interface (UART/I2C/SPI)	Limit access to the flash, cannot read out flash content	Send "FlashEraseAllUnsecureh" command or attempt to unlock flash security using the backdoor key

This device features 80-bit unique identification number, which is programmed in factory and loaded to SIM register after power-on reset.

## 2.1.8 Power management

The Power Management Controller (PMC) expands upon ARM's operational modes of Run, Sleep, and Deep Sleep, to provide multiple configurable modes. These modes can be used to optimize current consumption for a wide range of applications. The WFI or WFE instruction invokes a Wait or a Stop mode, depending on the current configuration. For more information on ARM's operational modes, See the ARM® Cortex User Guide.

- Configurable for short and long timeout values, the longest timeout is up to 262 seconds
- Support window mode

## 2.2 Peripheral features

The following sections describe the features of each peripherals of the chip.

### 2.2.1 BME

The Bit Manipulation Engine (BME) provides hardware support for atomic read-modify-write memory operations to the peripheral address space in Cortex-M0+ based microcontrollers. It reduces up to 30% of the code size and up to 9% of the cycles for bit-oriented operations to peripheral registers.

The BME supports unsigned bit field extract, load-and-set 1-bit, load-and-clear 1-bit, bit field insert, logical AND/OR/XOR operations with byte, halfword or word-sized data type.

### 2.2.2 DMA and DMAMUX

The DMA controller module enables fast transfers of data, which provides an efficient way to move blocks of data with minimal processor interaction. The DMA controller in this device implements four channels which can be routed from up to 63 DMA request sources through DMA MUX module. Some of the peripheral request sources have asynchronous DMA capability which can be used to wake MCU from Stop mode. The peripherals which have such capability include LPUART0, LPUART1, FlexIO, TPM0-TPM2, ADC0, CMP0, PORTA-PORTE. The DMA channel 0 and 1 can be periodically triggered by PIT via DMA MUX.

Main features are listed below:

- Dual-address transfers via 32-bit master connection to the system bus and data transfers in 8-, 16-, or 32-bit blocks
- Supports programmable source and destination address and transfer size, optional modulo addressing from 16 bytes to 256 KB
- Automatic updates of source and destination addresses

- Full-duplex or single-wire bidirectional mode
- Programmable transmit bit rate
- Double-buffered transmit and receive data register
- Serial clock phase and polarity options
- Slave select output
- Mode fault error flag with CPU interrupt capability
- Control of SPI operation during wait mode
- Selectable MSB-first or LSB-first shifting
- Programmable 8- or 16-bit data transmission length
- Receive data buffer hardware match feature
- 64-bit FIFO mode for high speed/large amounts of data transfers
- Support DMA

## 2.2.14 I2C

This device contains two I2C modules, which support up to 1 Mbits/s by dual buffer features, and address match to wake MCU from the low power mode.

I2C modules support DMA transfer, and the interrupt condition can trigger DMA request when DMA function is enabled.

The I2C modules have the following features:

- Support for system management bus (SMBus) Specification, version 2
- Software programmable for one of 64 different serial clock frequencies
- Software-selectable acknowledge bit
- Arbitration-lost interrupt with automatic mode switching from master to slave
- Calling address identification interrupt
- START and STOP signal generation and detection
- Repeated START signal generation and detection
- Acknowledge bit generation and detection
- Bus busy detection
- General call recognition
- 10-bit address extension
- Programmable input glitch filter
- Low power mode wakeup on slave address match
- Range slave address support
- DMA support
- Double buffering support to achieve higher baud rate

## Pinouts

64 LQFP	36 XFB GA	32 QFN	48 QFN	64 MAP BGA	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7
						ADC0_SE4a	ADC0_SE4a							
11	E1	—	—	G2	PTE22	ADC0_DP3/ ADC0_SE3	ADC0_DP3/ ADC0_SE3	PTE22		TPM2_CH0	UART2_TX		FXIO0_D6	
12	F1	—	—	F2	PTE23	ADC0_DM3/ ADC0_SE7a	ADC0_DM3/ ADC0_SE7a	PTE23		TPM2_CH1	UART2_RX		FXIO0_D7	
13	D3	7	9	F4	VDDA	VDDA	VDDA							
14	D3	7	10	G4	VREFH	VREFH	VREFH							
14	—	—	10	G4	VREFO	VREFO_A	VREFO_A							
15	D4	8	11	G3	VREFL	VREFL	VREFL							
16	D4	8	12	F3	VSSA	VSSA	VSSA							
17	—	—	13	H1	PTE29	CMP0_IN5/ ADC0_SE4b	CMP0_IN5/ ADC0_SE4b	PTE29		TPM0_CH2	TPM_CLKIN0			
18	F2	9	14	H2	PTE30	ADC0_SE23/ CMP0_IN4	ADC0_SE23/ CMP0_IN4	PTE30		TPM0_CH3	TPM_CLKIN1	LPUART1_TX	LPTMR0_ALT1	
19	—	—	—	H3	PTE31	DISABLED		PTE31		TPM0_CH4				
20	—	—	15	H4	PTE24	DISABLED		PTE24		TPM0_CH0		I2C0_SCL		
21	—	—	16	H5	PTE25	DISABLED		PTE25		TPM0_CH1		I2C0_SDA		
22	F3	10	17	D3	PTA0	SWD_CLK		PTA0		TPM0_CH5				SWD_CLK
23	F4	11	18	D4	PTA1	DISABLED		PTA1	LPUART0_RX	TPM2_CH0				
24	E4	12	19	E5	PTA2	DISABLED		PTA2	LPUART0_TX	TPM2_CH1				
25	E5	13	20	D5	PTA3	SWD_DIO		PTA3	I2C1_SCL	TPM0_CH0				SWD_DIO
26	F5	14	21	G5	PTA4	NMI_b		PTA4	I2C1_SDA	TPM0_CH1				NMI_b
27	—	—	—	F5	PTA5	DISABLED		PTA5		TPM0_CH2				
28	—	—	—	H6	PTA12	DISABLED		PTA12		TPM1_CH0				
29	—	—	—	G6	PTA13	DISABLED		PTA13		TPM1_CH1				
30	C3	15	22	G7	VDD	VDD	VDD							
31	C4	16	23	H7	VSS	VSS	VSS							
32	F6	17	24	H8	PTA18	EXTAL0	EXTAL0	PTA18		LPUART1_RX	TPM_CLKIN0			
33	E6	18	25	G8	PTA19	XTAL0	XTAL0	PTA19		LPUART1_TX	TPM_CLKIN1		LPTMR0_ALT1	
34	D5	19	26	F8	PTA20	RESET_b		PTA20						RESET_b
35	D6	20	27	F7	PTB0/ LLWU_P5	ADC0_SE8	ADC0_SE8	PTB0/ LLWU_P5	I2C0_SCL	TPM1_CH0	SPI1_MOSI	SPI1_MISO		
36	C6	21	28	F6	PTB1	ADC0_SE9	ADC0_SE9	PTB1	I2C0_SDA	TPM1_CH1	SPI1_MISO	SPI1_MOSI		



**Table 17. TPM1 signal descriptions**

Chip signal name	Module signal name	Description	I/O
TPM_CLKIN[1:0]	TPM_EXTCLK	External clock. TPM external clock can be selected to increment the TPM counter on every rising edge synchronized to the counter clock.	I
TPM1_CH[1:0]	TPM_CHn	TPM channel (n = 1 to 0). A TPM channel pin is configured as output when configured in an output compare or PWM mode and the TPM counter is enabled, otherwise the TPM channel pin is an input.	I/O

**Table 18. TPM2 signal descriptions**

Chip signal name	Module signal name	Description	I/O
TPM_CLKIN[1:0]	TPM_EXTCLK	External clock. TPM external clock can be selected to increment the TPM counter on every rising edge synchronized to the counter clock.	I
TPM2_CH[1:0]	TPM_CHn	TPM channel (n = 1 to 0). A TPM channel pin is configured as output when configured in an output compare or PWM mode and the TPM counter is enabled, otherwise the TPM channel pin is an input.	I/O

**Table 19. LPTMR0 signal descriptions**

Chip signal name	Module signal name	Description	I/O
LPTMR0_ALT[3:1]	LPTMR0_ALTN	Pulse Counter Input pin	I

**Table 20. RTC signal descriptions**

Chip signal name	Module signal name	Description	I/O
RTC_CLKOUT <sup>1</sup>	RTC_CLKOUT	1 Hz square-wave output or OSCERCLK	O

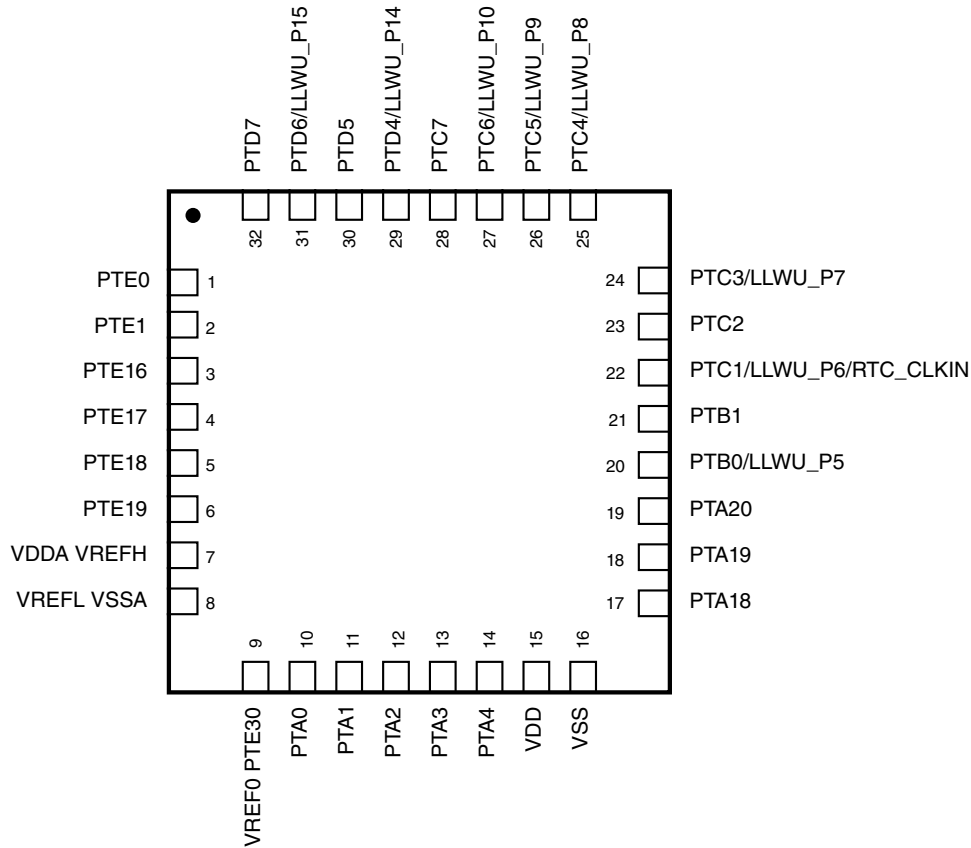
1. RTC\_CLKOUT can also be driven with OSCERCLK via SIM control bit SIM\_SOPT[RCTCLKOUTSEL]

## 4.3.6 Communication interfaces

**Table 21. SPI0 signal descriptions**

Chip signal name	Module signal name	Description	I/O
SPI0_MISO	MISO	Master Data In, Slave Data Out	I/O

Table continues on the next page...

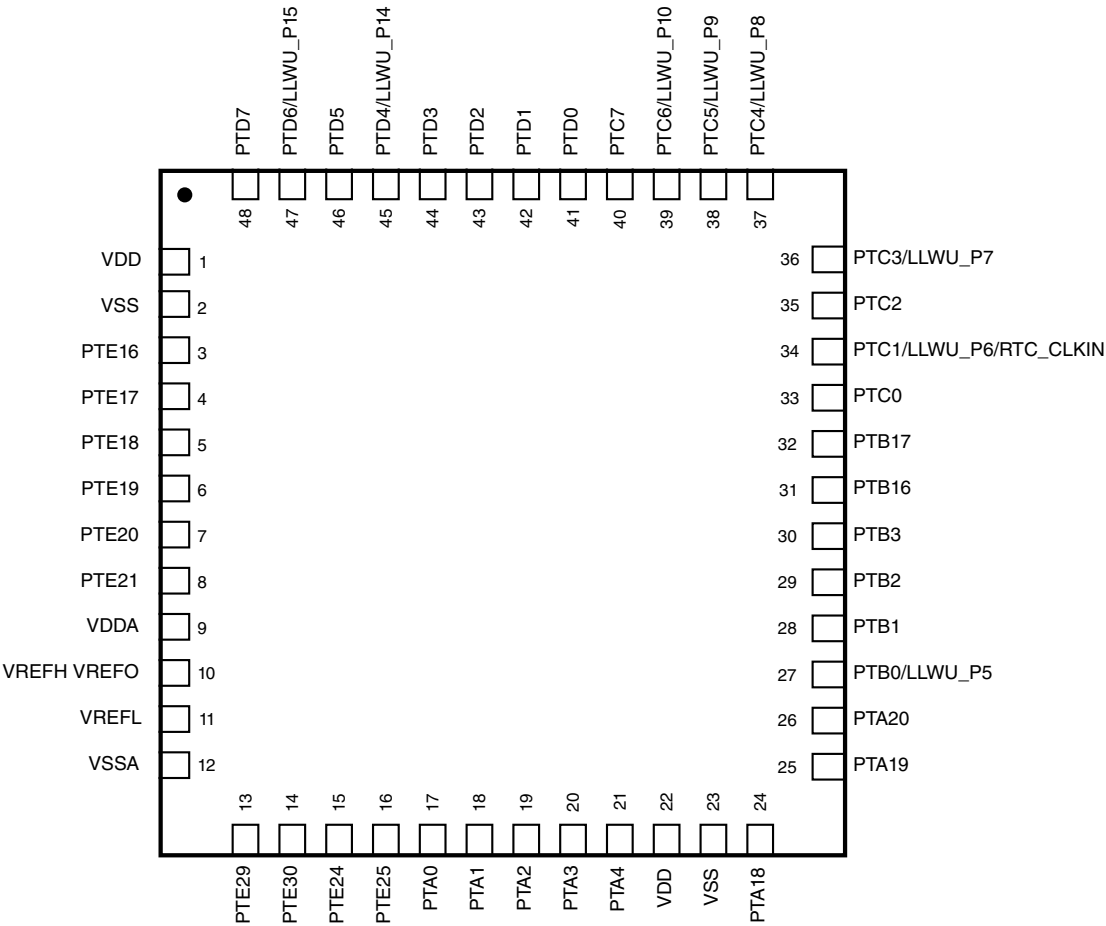


**Figure 6. 32 QFN Pinout diagram (transparent top view)**

The figure below shows the 48 QFN pinouts.

**NOTE**

The 48 QFN package for this product is not yet available. However, it is included in Package Your Way program for Kinetis MCUs. Visit [freescale.com/KPYW](http://freescale.com/KPYW) for more details.



**Figure 7. 48 QFN Pinout diagram (transparent top view)**

The figure below shows the 64 MAPBGA pinouts.

**NOTE**

The 64 MAPBGA package for this product is not yet available. However, it is included in Package Your Way program for Kinetis MCUs. Visit [freescale.com/KPYW](http://freescale.com/KPYW) for more details.

	1	2	3	4	5	6	
A	PTE0	PTD7	PTD4/ LLWU_P14	PTC7	PTC5/ LLWU_P9	PTC4/ LLWU_P8	A
B	PTE1	PTD6/ LLWU_P15	PTD5	PTC6/ LLWU_P10	PTC3/ LLWU_P7	PTC2	B
C	PTE17	PTE16	VDD	VSS	PTC1/ LLWU_P6/ RTC_CLKIN	PTB1	C
D	PTE18	PTE19	VDDA/ VREFH	VREFL/ VSSA	PTA20	PTB0/ LLWU_P5	D
E	PTE22	PTE21	PTE20	PTA2	PTA3	PTA19	E
F	PTE23	VREF0/ PTE30	PTA0	PTA1	PTA4	PTA18	F
	1	2	3	4	5	6	

Figure 10. 36 XFBGA Pinout diagram (transparent top view)

### 4.5 Package dimensions

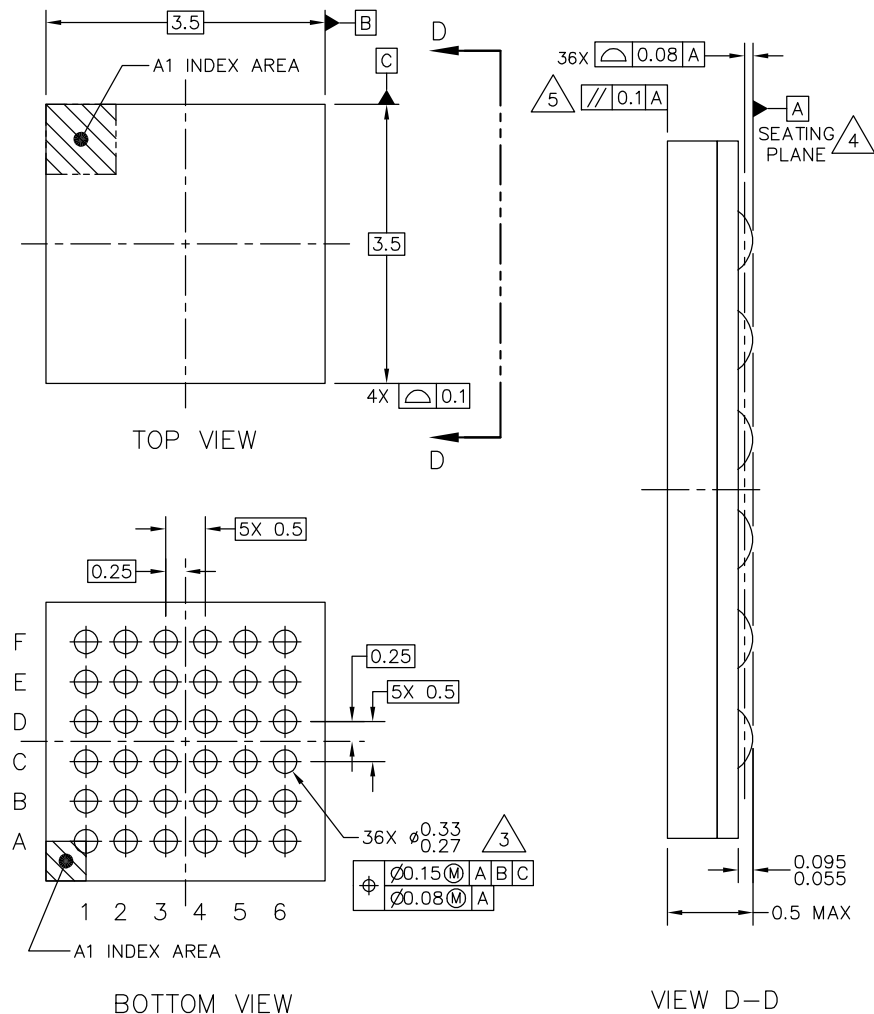
The following figures show the dimensions of the package options for the devices supported by this document.



4. COPLANARITY APPLIES TO LEADS AND DIE ATTACH FLAG.

5. MIN. METAL GAP SHOULD BE 0.2 MM.

### Figure 15. 48-pin QFN package dimension 2



## NOTES:

1. ALL DIMENSIONS IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
3. MAXIMUM SOLDER BALL DIAMETER MEASURED PARALLEL TO DATUM A.
4. DATUM A, THE SEATING PLANE, IS DETERMINED BY THE SPHERICAL CROWNS OF THE SOLDER BALLS.
5. PARALLELISM MEASUREMENT SHALL EXCLUDE ANY EFFECT OF MARK ON TOP SURFACE OF PACKAGE.

**Figure 16. 36-pin XFBGA package dimension**

**Table 38. Power consumption operating behaviors (continued)**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
I <sub>DD_VLPS</sub>	Very-low-power stop mode current at 3.0 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	2.34	3.80	μA	
		—	5.04	8.03		
		—	20.48	31.97		
		—	42.34	65.78		
		—	42.34	65.78		
I <sub>DD_VLPS</sub>	Very-low-power stop mode current at 1.8 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	2.33	3.80	μA	
		—	4.95	7.94		
		—	20.18	31.57		
		—	41.93	65.17		
		—	41.93	65.17		
I <sub>DD_LLS</sub>	Low-leakage stop mode current, all peripheral disable, at 3.0 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 70 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	1.71	1.96	μA	
		—	2.59	3.30		
		—	4.46	7.06		
		—	7.55	10.15		
		—	17.03	22.67		
		—	17.03	22.67		
I <sub>DD_LLS</sub>	Low-leakage stop mode current with RTC current, at 3.0 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 70 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	2.27	2.52	μA	3
		—	3.1	3.81		
		—	4.99	7.59		
		—	8.1	10.70		
		—	17.32	22.96		
		—	17.32	22.96		
I <sub>DD_LLS</sub>	Low-leakage stop mode current with RTC current, at 1.8 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 70 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	2.1	2.35	μA	3
		—	2.89	3.60		
		—	4.65	7.25		
		—	7.61	10.21		
		—	16.38	22.02		
		—	16.38	22.02		
I <sub>DD_VLLS3</sub>	Very-low-leakage stop mode 3 current, all peripheral disable, at 3.0 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 70 °C</li> </ul>	—	1.43	1.58	μA	
		—	2.06	2.52		
		—	3.51	5.20		
		—	5.91	7.60		
		—	13.36	17.08		

Table continues on the next page...

1. The maximum value represents characterized results equivalent to the mean plus or minus three times the standard deviation (mean $\pm$ 3 sigma).
2. IRC48M startup time is defined as the time between clock enablement and clock availability for system use. Enable the clock by one of the following settings:
  - MCG operating in an external clocking mode and MCG\_C7[OSCSEL]=10, or
  - SIM\_SOPT2[PLLFLSEL]=11

**Table 47. IRC8M/2M specification**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
I <sub>DD_2M</sub>	Supply current in 2 MHz mode	—	14	17	μA	—
I <sub>DD_8M</sub>	Supply current in 8 MHz mode	—	30	35	μA	—
f <sub>IRC_2M</sub>	Output frequency	—	2	—	MHz	—
f <sub>IRC_8M</sub>	Output frequency	—	8	—	MHz	—
f <sub>IRC_T_2M</sub>	Output frequency range (trimmed)	—	—	±3	%f <sub>IRC</sub>	—
f <sub>IRC_T_8M</sub>	Output frequency range (trimmed)	—	—	±3	%f <sub>IRC</sub>	—
T <sub>su_2M</sub>	Startup time	—	—	12.5	μs	—
T <sub>su_8M</sub>	Startup time	—	—	12.5	μs	—

### 5.3.3.2 Oscillator electrical specifications

#### 5.3.3.2.1 Oscillator DC electrical specifications

**Table 48. Oscillator DC electrical specifications**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
V <sub>DD</sub>	Supply voltage	1.71	—	3.6	V	
I <sub>DDOSC</sub>	Supply current — low-power mode (HGO=0)					1
	• 32 kHz	—	500	—	nA	
	• 4 MHz	—	200	—	μA	
	• 8 MHz (RANGE=01)	—	300	—	μA	
	• 16 MHz	—	950	—	μA	
	• 24 MHz	—	1.2	—	mA	
	• 32 MHz	—	1.5	—	mA	
I <sub>DDOSC</sub>	Supply current — high gain mode (HGO=1)					1
	• 32 kHz	—	25	—	μA	
	• 4 MHz	—	400	—	μA	
	• 8 MHz (RANGE=01)	—	500	—	μA	
	• 16 MHz	—	2.5	—	mA	
	• 24 MHz	—	3	—	mA	
	• 32 MHz	—	4	—	mA	

Table continues on the next page...



**Table 53. NVM reliability specifications (continued)**

Symbol	Description	Min.	Typ. <sup>1</sup>	Max.	Unit	Notes
$t_{\text{nvmretp10k}}$	Data retention after up to 10 K cycles	5	50	—	years	—
$t_{\text{nvmretp1k}}$	Data retention after up to 1 K cycles	20	100	—	years	—
$n_{\text{nvmcycp}}$	Cycling endurance	10 K	50 K	—	cycles	2

1. Typical data retention values are based on measured response accelerated at high temperature and derated to a constant 25 °C use profile. Engineering Bulletin EB618 does not apply to this technology. Typical endurance defined in Engineering Bulletin EB619.
2. Cycling endurance represents number of program/erase cycles at  $-40\text{ °C} \leq T_j \leq 125\text{ °C}$ .

### 5.3.5 Security and integrity modules

There are no specifications necessary for the device's security and integrity modules.

### 5.3.6 Analog

#### 5.3.6.1 ADC electrical specifications

Using differential inputs can achieve better system accuracy than using single-end inputs.

##### 5.3.6.1.1 16-bit ADC operating conditions

**Table 54. 16-bit ADC operating conditions**

Symbol	Description	Conditions	Min.	Typ. <sup>1</sup>	Max.	Unit	Notes
$V_{\text{DDA}}$	Supply voltage	Absolute	1.71	—	3.6	V	—
$\Delta V_{\text{DDA}}$	Supply voltage	Delta to $V_{\text{DD}}$ ( $V_{\text{DD}} - V_{\text{DDA}}$ )	-100	0	+100	mV	2
$\Delta V_{\text{SSA}}$	Ground voltage	Delta to $V_{\text{SS}}$ ( $V_{\text{SS}} - V_{\text{SSA}}$ )	-100	0	+100	mV	2
$V_{\text{ADIN}}$	Input voltage	<ul style="list-style-type: none"> <li>16-bit differential mode</li> <li>All other modes</li> </ul>	VREFL VREFL	— —	$31/32 \times V_{\text{REFH}}$ VREFH	V	—
$C_{\text{ADIN}}$	Input capacitance	<ul style="list-style-type: none"> <li>16-bit mode</li> <li>8-bit / 10-bit / 12-bit modes</li> </ul>	— —	8 4	10 5	pF	—
$R_{\text{ADIN}}$	Input series resistance		—	2	5	k $\Omega$	—
$R_{\text{AS}}$	Analog source resistance (external)	13-bit / 12-bit modes $f_{\text{ADCK}} < 4\text{ MHz}$	—	—	5	k $\Omega$	3

Table continues on the next page...

**Table 55. 16-bit ADC characteristics ( $V_{REFH} = V_{DDA}$ ,  $V_{REFL} = V_{SSA}$ ) (continued)**

Symbol	Description	Conditions <sup>1</sup>	Min.	Typ. <sup>2</sup>	Max.	Unit	Notes
		• Avg = 32					
SFDR	Spurious free dynamic range	16-bit differential mode • Avg = 32	82	95	—	dB	7
		16-bit single-ended mode • Avg = 32	78	90	—	dB	
E <sub>IL</sub>	Input leakage error		$I_{in} \times R_{AS}$			mV	$I_{in}$ = leakage current (refer to the MCU's voltage and current operating ratings)
	Temp sensor slope	Across the full temperature range of the device	1.55	1.62	1.69	mV/°C	8
V <sub>TEMP25</sub>	Temp sensor voltage	25 °C	706	716	726	mV	8

1. All accuracy numbers assume the ADC is calibrated with  $V_{REFH} = V_{DDA}$
2. Typical values assume  $V_{DDA} = 3.0$  V, Temp = 25 °C,  $f_{ADCK} = 2.0$  MHz unless otherwise stated. Typical values are for reference only and are not tested in production.
3. The ADC supply current depends on the ADC conversion clock speed, conversion rate and ADC\_CFG1[ADLPC] (low power). For lowest power operation, ADC\_CFG1[ADLPC] must be set, the ADC\_CFG2[ADHSC] bit must be clear with 1 MHz ADC conversion clock speed.
4. 1 LSB =  $(V_{REFH} - V_{REFL})/2^N$
5. ADC conversion clock < 16 MHz, Max hardware averaging (AVGE = %1, AVGS = %11)
6. Input data is 100 Hz sine wave. ADC conversion clock < 12 MHz.
7. Input data is 1 kHz sine wave. ADC conversion clock < 12 MHz.
8. ADC conversion clock < 3 MHz

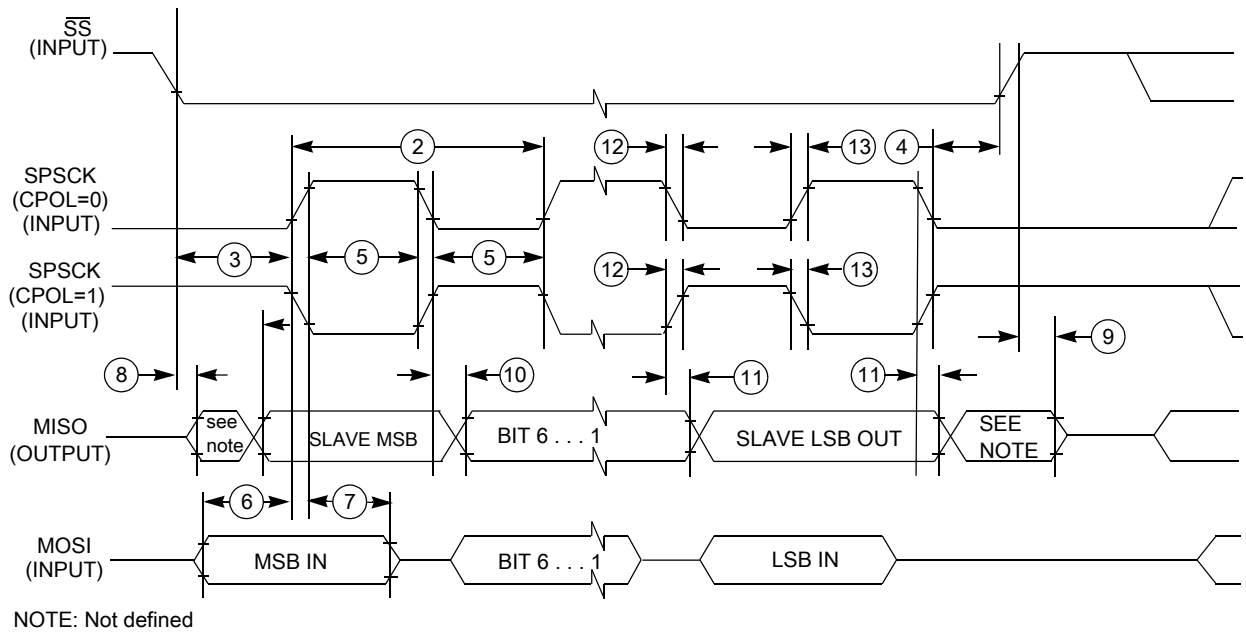


Figure 31. SPI slave mode timing (CPHA = 0)

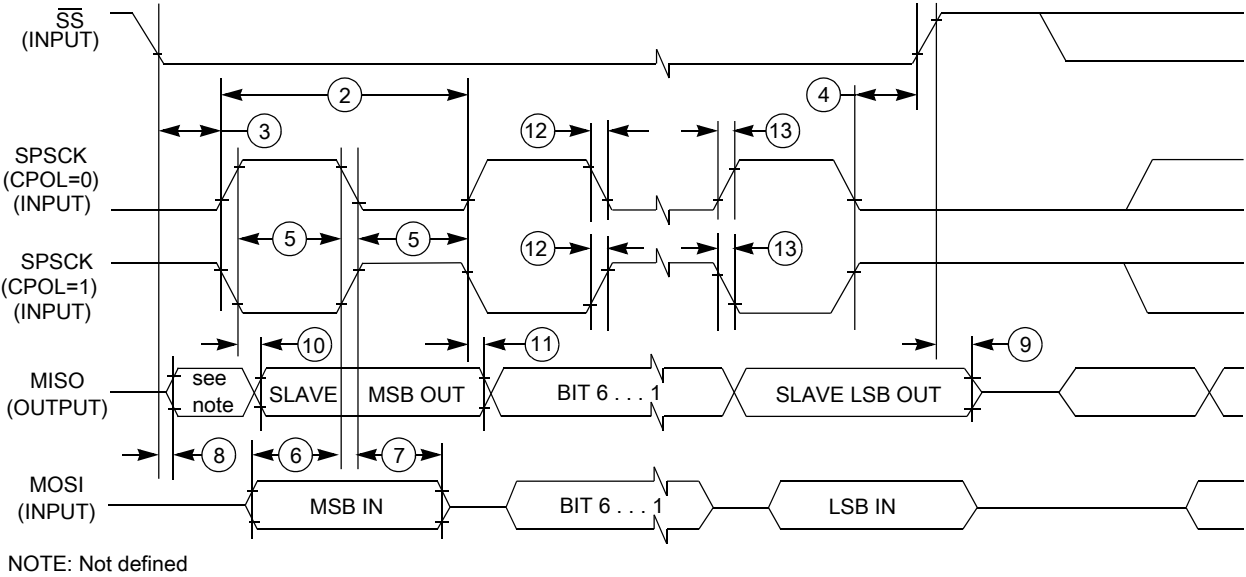


Figure 32. SPI slave mode timing (CPHA = 1)

**Table 67. Part number fields description (continued)**

Field	Description	Values
N	Packaging type	<ul style="list-style-type: none"> <li>R = Tape and reel</li> <li>(Blank) = Trays</li> </ul>

1. This package for this product is not yet available. However, it is included in Package Your Way program for Kinetis MCUs. Visit [freescale.com/KPYW](http://freescale.com/KPYW) for more details.

## 7.4 Example

This is an example part number:

MKL17Z64VLH4

## 8 Revision history

The following table provides a revision history for this document.

**Table 68. Revision history**

Rev. No.	Date	Substantial Changes
4	28 January/ 2015	Initial public release <ul style="list-style-type: none"> <li>Updated the features and completed the ordering information.</li> <li>Updated Table 9 - Power consumption operating behaviors with Max. values.</li> <li>Added a note before Table 9.</li> <li>Updated Table 17 - IRC48M specifications.</li> <li>Updated Table 28. VREF full-range (-40 – 105 °C) operating behaviors with Min., Max., and Typical values.</li> <li>Added Table 36 - I<sup>2</sup>C 1Mbit/s timing.</li> </ul>
4.1	2 February/ 2015	<ul style="list-style-type: none"> <li>Moved the ordering information out of the front page to be a separate chapter.</li> <li>Added Module signal description table and Package dimension sections.</li> </ul>
5	21 April/2015	<ul style="list-style-type: none"> <li>32-pin QFN package is now standard part, added Marking information and thermal attributes of this package</li> <li>Added <a href="#">Overview</a> chapter</li> <li>Added <a href="#">Memory map</a> chapter</li> <li>Added <a href="#">Pin properties</a></li> <li>Added a note to the t<sub>rd1all</sub> in <a href="#">Flash timing specifications — commands</a></li> <li>Added a note to the Maximum of f<sub>SCL</sub> in the fast mode in <a href="#">Inter-Integrated Circuit Interface (I2C) timing</a></li> <li>Added a footnote to the Δfirc48m_ol_hv in <a href="#">MCG-Lite specifications</a></li> <li>Added <a href="#">Design considerations</a> chapter</li> </ul>

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